

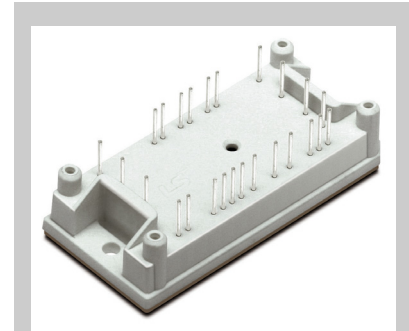
### Features

- Trench Field Stop technology IGBT adopted
- Low saturation voltage
- Positive temperature coefficient
- Fast switching
- Free wheeling diodes with fast and soft reverse recovery
- Industrial standard package with insulated substrate
- Temperature sensor included
- Input from single or three phase grid
- Dynamic braking operation

### Applications

- Three phase synchronous or asynchronous motor drive

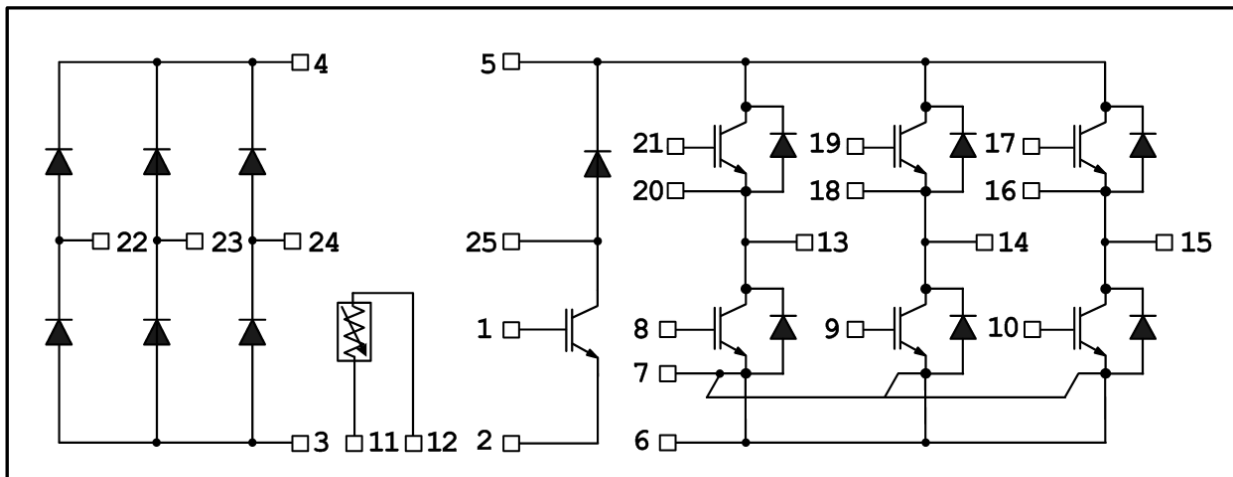
### Preliminary Data



**SISPM1**

82.2 x 37.9 x 21.7mm

### Internal Equivalent Circuit



### Pin Description

Pin Number	Pin Name	Pin Description
1	GB	Gate Input for Braking IGBT
2	EB	Emitter Input for Braking IGBT
3	DCN	Negative DC Link Input
4	DCP	Positive DC Link Input
5	P	Positive DC Link Output
6	N	Negative DC Link Output
7	COM	Common Supply Ground
8, 9, 10	GUN, GVN, GWN	Gate Input for Low-side U Phase, V Phase, W Phase
11, 12	TH1, TH2	NTC-, NTC+
13, 14, 15	U, V, W	Output for U Phase, V Phase, W Phase
16, 18, 20	EWP, EVP, EUP	Emitter Input for High-side W Phase, V Phase, U Phase
17, 19, 21	GWP, GVP, GUP	Gate Input for High-side W Phase, V Phase, U Phase
22, 23, 24	R, S, T	Input for R Phase, S Phase, T Phase
25	B	Output for Braking

## Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted

Item	Symbol	Parameter	Conditions	Value	Units
Input Rectifier	$V_{RRM}$	Repetitive Peak Reverse Voltage		1600	V
	$I_{FAV}$	Forward Current per Diode	@ $T_j = 150^\circ\text{C}$ , $T_C = 80^\circ\text{C}$	20	A
	$I_{FSM}$	Surge Forward Current (Chip level)	@ $t_p = 10\text{ ms}$ , half sine wave	220	A
	$I^2t$	$I^2t$ - Value (Chip level)	@ $t_p = 10\text{ ms}$ , half sine wave	200	$\text{A}^2\text{s}$
	$P_D$	Maximum Power Dissipation	@ $T_j = 150^\circ\text{C}$ , $T_C = 80^\circ\text{C}$	40	W
	$T_j$	Operating Junction Temperature <sup>(1)</sup>	-	-40 ~ 125	$^\circ\text{C}$
Transistor Inverter	$V_{CES}$	Collector-Emitter Breakdown Voltage	-	600	V
	$V_{GES}$	Gate-Emitter Peak Voltage	-	$\pm 20$	V
	$I_C$	DC Collector Current	@ $T_j = 175^\circ\text{C}$ , $T_C = 80^\circ\text{C}$	20	A
	$I_{cpulse}$	Repetitive Peak Collector Current	@ $t_p = 1\text{ ms}$	40	A
	$P_D$	Maximum Power Dissipation	@ $T_j = 175^\circ\text{C}$ , $T_C = 80^\circ\text{C}$	50	W
	$T_{SC}$	SC Withstand Time (Chip level)	$V_{GE} = 15\text{ V}$ , $V_{CE} = 300\text{ V}$	5	$\mu\text{s}$
	$T_j$	Operating Junction Temperature <sup>(2)</sup>	-	-40 ~ 125	$^\circ\text{C}$
Diode Inverter	$V_{RRM}$	Repetitive Peak Reverse Voltage	-	600	V
	$I_F$	DC Forward Current	@ $T_j = 175^\circ\text{C}$ , $T_C = 70^\circ\text{C}$	20	A
	$I_{FRM}$	Repetitive Peak Forward Current	@ $t_p = 1\text{ ms}$	40	A
	$P_D$	Maximum Power Dissipation	@ $T_j = 175^\circ\text{C}$ , $T_C = 70^\circ\text{C}$	40	W
	$T_j$	Operating Junction Temperature <sup>(2)</sup>	-	-40 ~ 125	$^\circ\text{C}$
Transistor Brake	$V_{CES}$	Collector-Emitter Breakdown Voltage	-	600	V
	$V_{GES}$	Gate-Emitter Peak Voltage	-	$\pm 20$	V
	$I_C$	DC Collector Current	@ $T_j = 175^\circ\text{C}$ , $T_C = 80^\circ\text{C}$	20	A
	$I_{cpulse}$	Repetitive Peak Collector Current	@ $t_p = 1\text{ ms}$	40	A
	$P_D$	Maximum Power Dissipation	@ $T_j = 175^\circ\text{C}$ , $T_C = 80^\circ\text{C}$	45	W
	$T_{SC}$	SC Withstand Time (Chip level)	@ $V_{GE} = 15\text{ V}$ , $V_{CE} = 300\text{ V}$	5	$\mu\text{s}$
	$T_j$	Operating Junction Temperature <sup>(2)</sup>	-	-40 ~ 125	$^\circ\text{C}$
Diode Brake	$V_{RRM}$	Repetitive Peak Reverse Voltage	-	600	V
	$I_F$	DC Forward Current	@ $T_j = 175^\circ\text{C}$ , $T_C = 70^\circ\text{C}$	20	A
	$I_{FRM}$	Repetitive Peak Forward Current	@ $t_p = 1\text{ ms}$	40	A
	$P_D$	Maximum Power Dissipation	@ $T_j = 175^\circ\text{C}$ , $T_C = 70^\circ\text{C}$	40	W
	$T_j$	Operating Junction Temperature <sup>(2)</sup>	-	-40 ~ 125	$^\circ\text{C}$
Module	$T_{stg}$	Storage Temperature	-	-40~125	$^\circ\text{C}$
	$V_{iso}$	Isolation Voltage	@ AC 1minute	2500	V
	W	Weight	-	50	g

(Note \*1) The Maximum junction temperature of chip is  $150^\circ\text{C}$ .

(Note \*2) The Maximum junction temperature of chip is  $175^\circ\text{C}$ .

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## Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

### Input Rectifier Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Units
$V_F$	Diode Forward Voltage	$T_C = 25^\circ\text{C}, I_F = 20\text{ A}$	-	1.2	-	V
		$T_C = 125^\circ\text{C}, I_F = 20\text{ A}$	-	1.1	-	V
$V_{to}$	Threshold Voltage	$T_C = 125^\circ\text{C}$	-	0.83	-	V
$I_R$	Reverse Current (Chip level)	$T_C = 25^\circ\text{C}, V_{RRM} = 300\text{ V}$	-	0.1	-	mA
$r_t$	Slope Resistance	$T_C = 125^\circ\text{C}$	-	20.8	-	m $\Omega$
$R_{th(J-C)}$	Thermal Resistance (IGBT Part)	Junction-to-Case	-	1.3	-	$^\circ\text{C/W}$

### Transistor-Inverter Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Units
$V_{GE(th)}$	Gate-Emitter threshold Voltage	$V_{CE} = V_{GE}, I_{CE} = 20\text{mA}$	-	5.6	-	V
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$T_C = 25^\circ\text{C}, I_{CE} = 20\text{ A}, V_{GE} = 15\text{ V}$	-	1.9	-	V
		$T_C = 125^\circ\text{C}, I_{CE} = 20\text{ A}, V_{GE} = 15\text{ V}$	-	2.3	-	V
$I_{CES}$	Collector-Emitter Cut-off Current	$V_{GE} = 0\text{ V}, V_{CE} = 300\text{ V}$	-	-	250	$\mu\text{A}$
$I_{CES}$	Gate-Emitter Leakage Current	$V_{GE} = \pm 20\text{ V}, V_{CE} = 0\text{ V}$	-	-	-	A
$C_{iss}$	Input Capacitance	$V_{CE} = 50\text{ V}, V_{GE} = 0\text{ V}$ $f = 100\text{ kHz}, T_C = 25^\circ\text{C}$ (Chip level)	-	-	-	nF
$C_{oss}$	Output Capacitance		-	-	-	nF
$C_{rss}$	Reverse Transfer Capacitance		-	-	-	nF
$t_d(on)$	Turn-On Delay Time	$T_C = 125^\circ\text{C}, R_{G ON} = 50\ \Omega$ $R_{G OFF} = 25\ \Omega, L = 500\ \mu\text{H}$ $V_{CE} = 300\text{ V}, V_{GE} = 0\text{ V} \sim 15\text{ V}$ $I_{CE} = 20\text{ A}$	-	67	-	ns
$t_r$	Rise Time		-	52	-	ns
$t_d(off)$	Turn-Off Delay Time		-	138	-	ns
$t_f$	Fall Time		-	37	-	ns
$E_{on}$	Turn-On Switching Loss		-	0.69	-	mJ
$E_{off}$	Turn-Off Switching Loss	-	0.28	-	mJ	
$E_{ts}$	Total Switching Loss	-	0.97	-	mJ	
$Q_G$	Total Gate Charge	$V_{GE} = 0\text{ V} \sim 15\text{ V}$	-	56	-	nC
$Q_{GE}$	Gate-Emitter Charge		-	23	-	nC
$Q_{GC}$	Gate-Collector Charge		-	15	-	nC
$R_{th(J-C)}$	Thermal Resistance (IGBT Part)	Junction-to-Case	-	1.5	-	$^\circ\text{C/W}$

### Diode-Inverter Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Units
$V_F$	Diode Forward Voltage	$I_F = 20\text{ A}, V_{GE} = 0\text{ V}$ $T_C = 125^\circ\text{C}$	-	1.7	-	V
$t_{rr}$	Diode Reverse Recovery Time	$R_{G ON} = 50\ \Omega$ $T_C = 125^\circ\text{C}$ $L = 500\ \mu\text{H}$	-	465	-	ns
$I_{RRM}$	Diode Peak Reverse Recovery Current	$V_{CE} = 300\text{ V}$ $T_C = 125^\circ\text{C}$ $V_{GE} = 0\text{ V} \sim 15\text{ V}$	-	19	-	A
$Q_{rr}$	Diode Reverse Recovery Charge	$I_{CE} = 20\text{ A}$ $T_C = 125^\circ\text{C}$	-	2.3	-	$\mu\text{C}$
$E_{rr}$	Diode Reverse Recovery Energy	$T_C = 125^\circ\text{C}$	-	0.48	-	mJ
$R_{th(J-C)}$	Thermal Resistance (IGBT Part)	Junction-to-Case	-	2.1	-	$^\circ\text{C/W}$

### Transistor- Brake Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Units
$V_{GE(th)}$	Gate-Emitter threshold Voltage	$V_{CE} = V_{GE}, I_{CE} = 20\text{mA}$	-	5.6	-	V
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$T_C = 25^\circ\text{C}, I_{CE} = 20\text{ A}, V_{GE} = 15\text{ V}$	-	1.9	-	V
		$T_C = 125^\circ\text{C}, I_{CE} = 20\text{ A}, V_{GE} = 15\text{ V}$	-	2.3	-	V
$I_{CES}$	Collector-Emitter Cut-off Current	$V_{GE} = 0\text{ V}, V_{CE} = 300\text{ V}$	-	-	250	$\mu\text{A}$
$I_{CES}$	Gate-Emitter Leakage Current	$V_{GE} = \pm 20\text{ V}, V_{CE} = 0\text{ V}$	-	-	-	A
$C_{iss}$	Input Capacitance	$V_{CE} = 50\text{ V}, V_{GE} = 0\text{ V}$ $f = 100\text{ kHz}, T_C = 25^\circ\text{C}$ (Chip level)	-	-	-	nF
$C_{oss}$	Output Capacitance		-	-	-	nF
$C_{rss}$	Reverse Transfer Capacitance		-	-	-	nF

Symbol	Parameter	Conditions	Min	Typ	Max	Units
$t_d(\text{on})$	Turn-On Delay Time	$T_C = 125^\circ\text{C}$ , $R_{G\text{ON}} = 50\ \Omega$ $R_{G\text{OFF}} = 25\ \Omega$ , $L = 500\ \mu\text{H}$ $V_{CE} = 300\ \text{V}$ , $V_{GE} = 0\ \text{V} \sim 15\ \text{V}$ $I_{CE} = 20\ \text{A}$	-	58	-	ns
$t_r$	Rise Time		-	57	-	ns
$t_d(\text{off})$	Turn-Off Delay Time		-	145	-	ns
$t_f$	Fall Time		-	19	-	ns
$E_{\text{on}}$	Turn-On Switching Loss		-	0.71	-	mJ
$E_{\text{off}}$	Turn-Off Switching Loss		-	0.25	-	mJ
$E_{\text{ts}}$	Total Switching Loss		-	0.96	-	mJ
$Q_G$	Total Gate Charge	$V_{GE} = 0\ \text{V} \sim 15\ \text{V}$	-	56	-	nC
$Q_{GE}$	Gate-Emitter Charge		-	23	-	nC
$Q_{GC}$	Gate-Collector Charge		-	15	-	nC
$R_{\text{th(J-C)}}$	Thermal Resistance (IGBT Part)	Junction-to-Case		1.6	-	$^\circ\text{C/W}$

## Diode-Brake Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

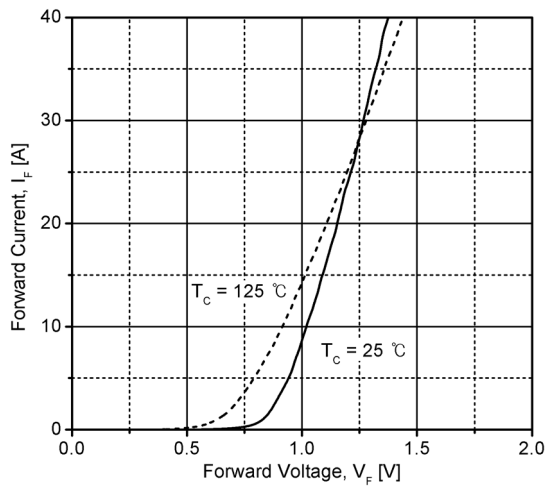
Symbol	Parameter	Test Conditions	Min	Typ	Max	Units	
$V_F$	Diode Forward Voltage	$I_F = 20\ \text{A}$ , $V_{GE} = 0\ \text{V}$ $T_C = 125^\circ\text{C}$	-	1.7	-	V	
$t_{rr}$	Diode Reverse Recovery Time	$R_{G\text{ON}} = 50\ \Omega$ $L = 500\ \mu\text{H}$ $V_{CE} = 300\ \text{V}$ $V_{GE} = 0\ \text{V} \sim 15\ \text{V}$ $I_{CE} = 20\ \text{A}$	-	485	-	ns	
$I_{RRM}$	Diode Peak Reverse Recovery Current		$T_C = 125^\circ\text{C}$	-	15	-	A
$Q_{rr}$	Diode Reverse Recovery Charge		$T_C = 125^\circ\text{C}$	-	2.1	-	$\mu\text{C}$
$E_{rr}$	Diode Reverse Recovery Energy		$T_C = 125^\circ\text{C}$	-	0.48	-	mJ
$R_{\text{th(J-C)}}$	Thermal Resistance (IGBT Part)	Junction-to-Case	-	2.1	-	$^\circ\text{C/W}$	

## NTC thermister Characteristics

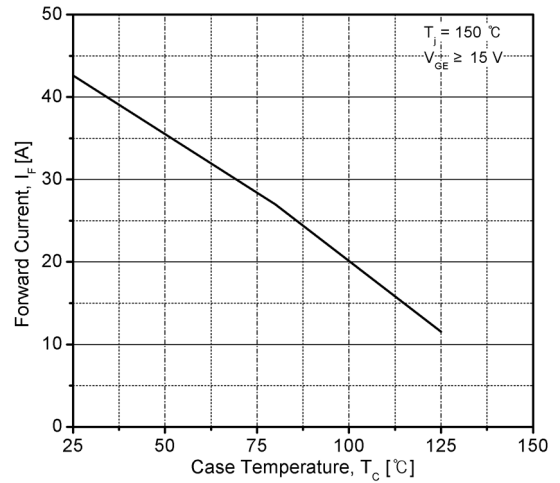
Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
$R_{25}$	Resistance	$T_C = 25^\circ\text{C}$	-	4.7	-	k $\Omega$
P	Power	$T_C = 25^\circ\text{C}$	-	210	-	mW
$B_{25/100}$	B Constant	$T_C = 25^\circ\text{C}$ , $\pm 3\%$ tolerance	-	3650	-	K

\* This specifications may not be considered as an assurance of characteristics and may not have same characteristics. in case of using different test systems from @LSIS. We therefore strongly recommend prior consultation of our engineers.

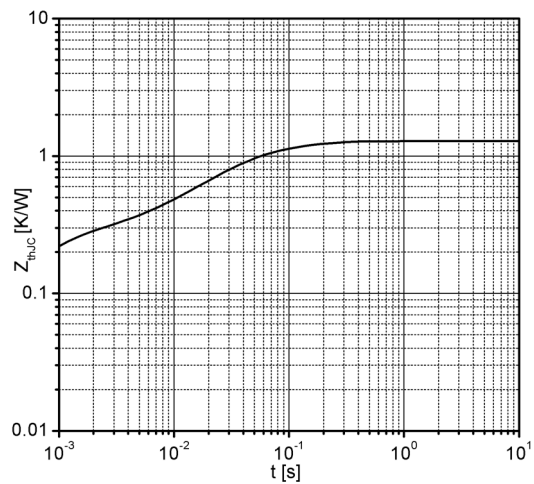
## Input rectifier



**Fig 1. Typical Diode Forward Characteristics**



**Fig 2. Case Temperature vs. Forward Current**



**Fig 3. Typical Diode Thermal Impedance**

Transistor-inverter/Diode-Inverter

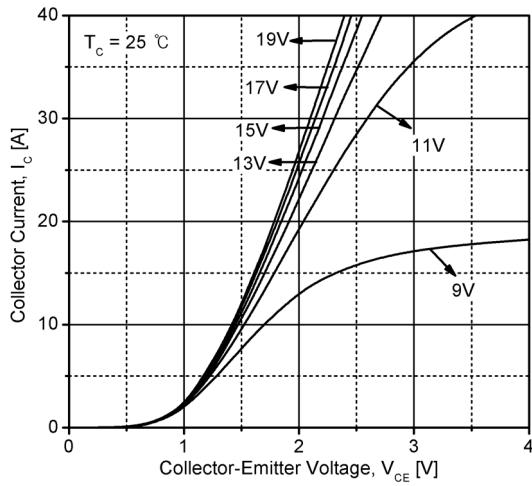


Fig 4. Typical IGBT Output Characteristics

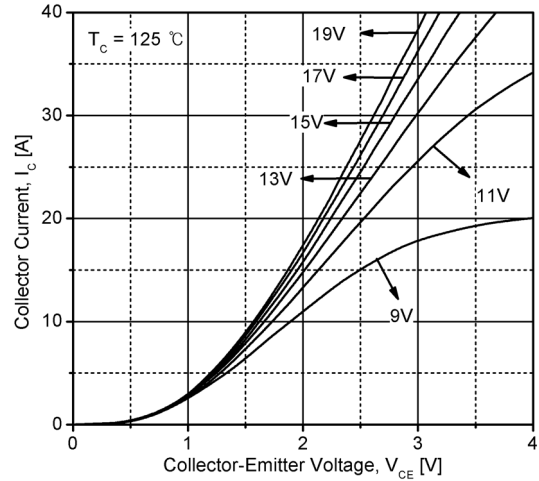


Fig 5. Typical IGBT Output Characteristics

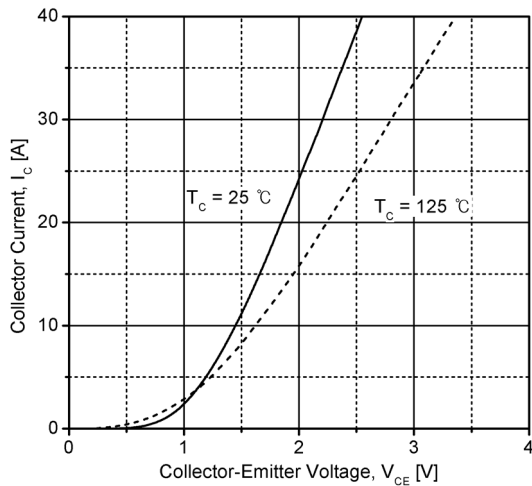


Fig 6. Typical IGBT Output Characteristics

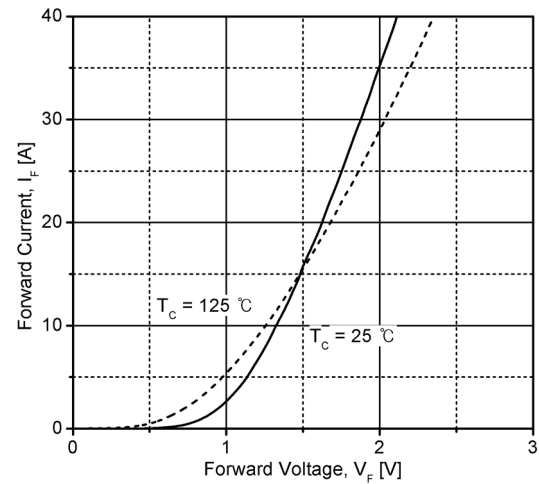


Fig 7. Typical Diode Forward Characteristics

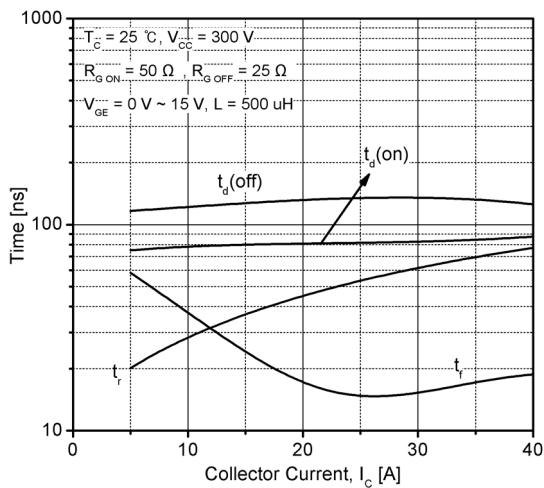


Fig 8. Typical Switching Time vs. Collector Current

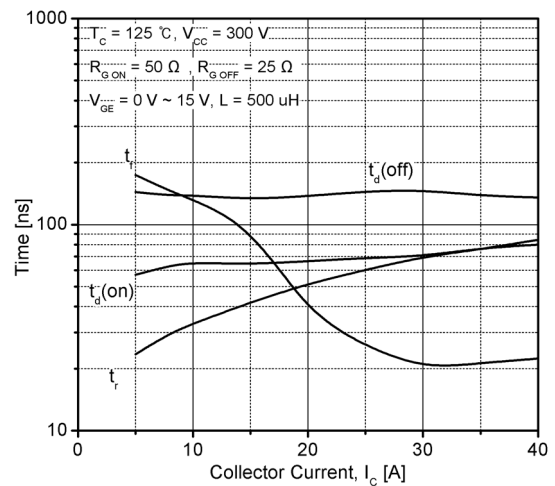


Fig 9. Typical Switching Time vs. Collector Current

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## Transistor-inverter/Diode-Inverter

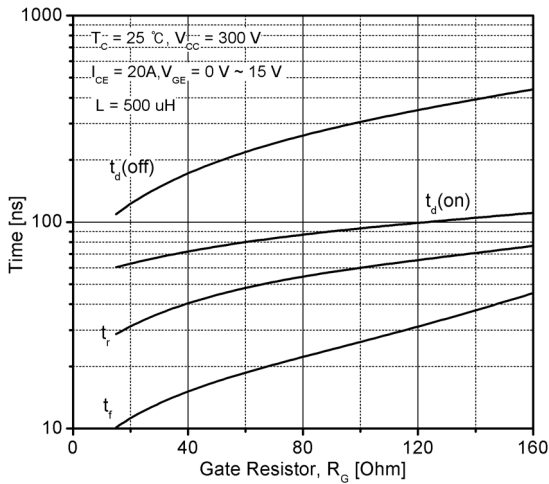


Fig 10. Typical Switching Time vs. Gate Resistor

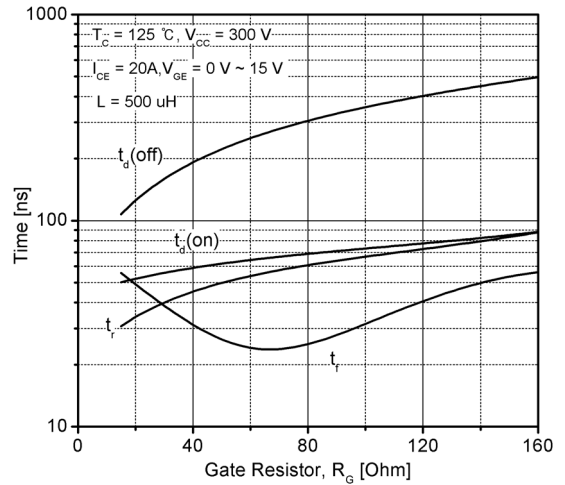


Fig 11. Typical Switching Time vs. Gate Resistor

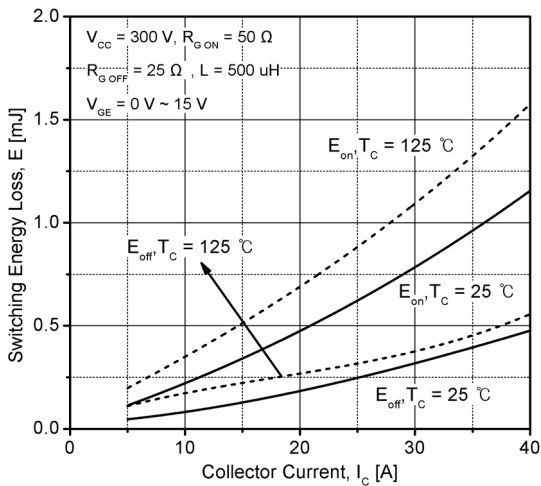


Fig 12. Typical IGBT Switching Loss

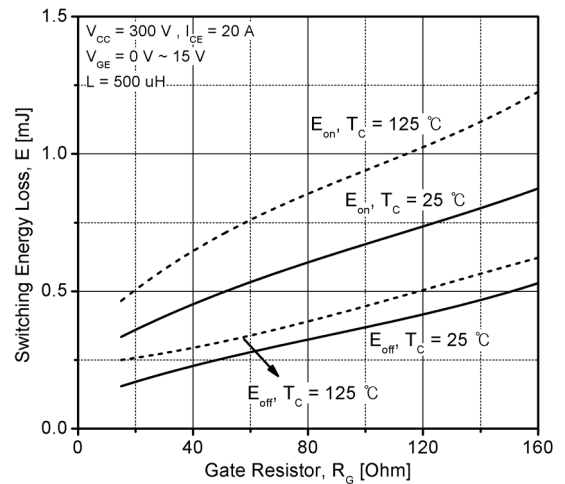


Fig 13. Typical IGBT Switching Loss

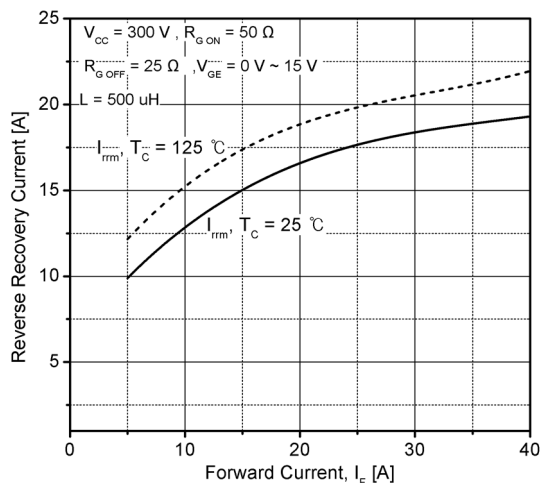


Fig 14. Typical Recovery Characteristics of Diode

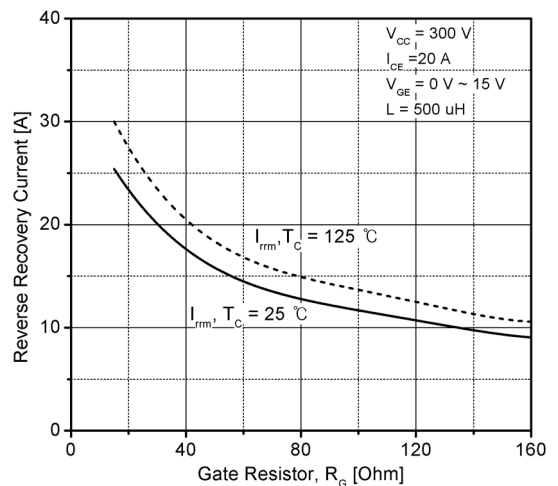


Fig 15. Typical Recovery Characteristics of Diode

Transistor-inverter/Diode-Inverter

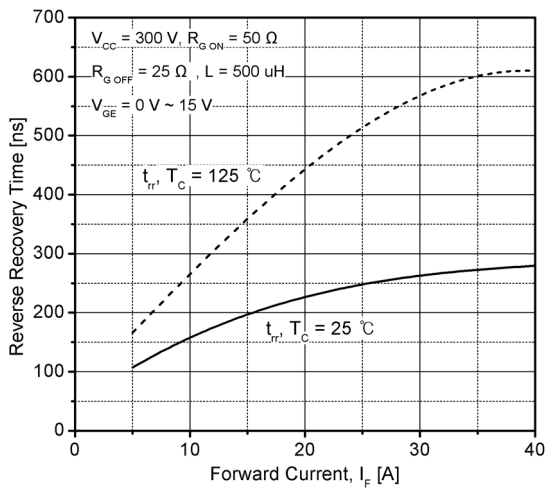


Fig 16. Typical Recovery Characteristics of Diode

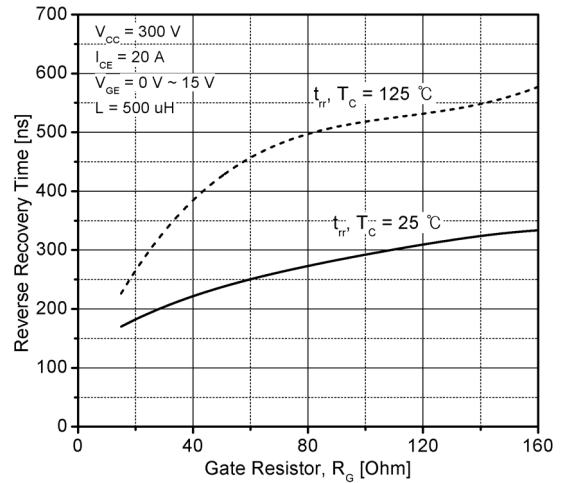


Fig 17. Typical Recovery Characteristics of Diode

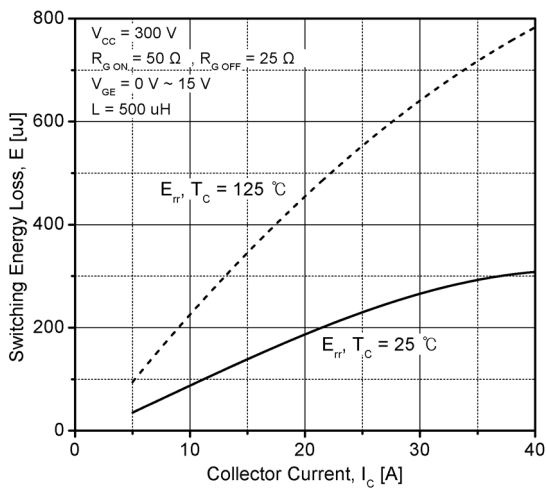


Fig 18. Typical Diode Switching Loss

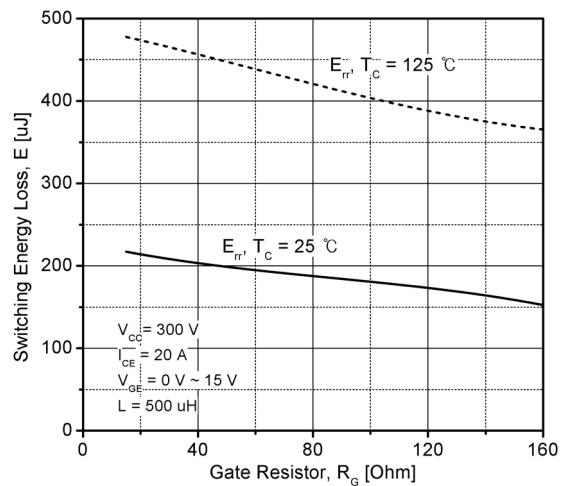


Fig 19. Typical Diode Switching Loss

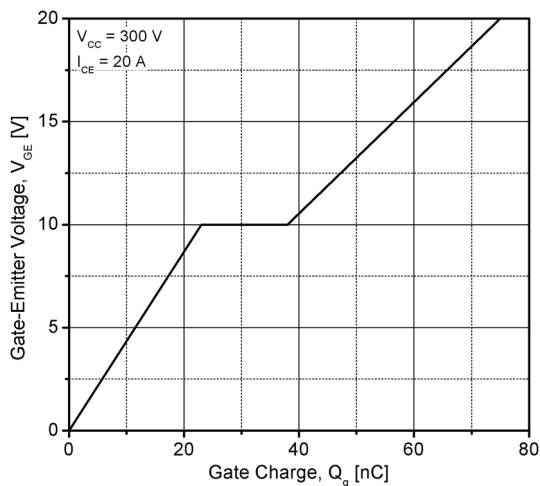


Fig 20. Typical Gate Charge Characteristics

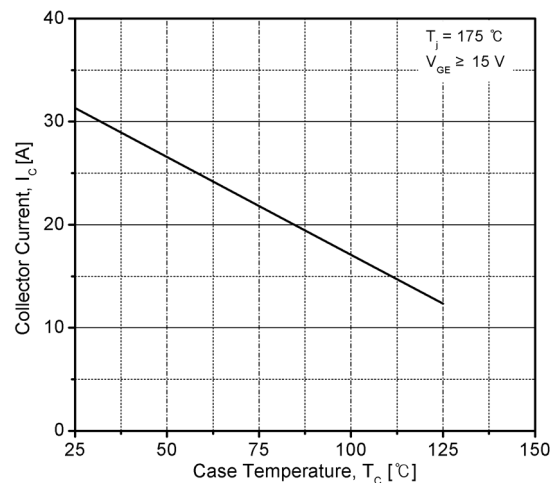


Fig 21. Case Temperature vs. Collector Current



## Transistor-inverter/Diode-Inverter

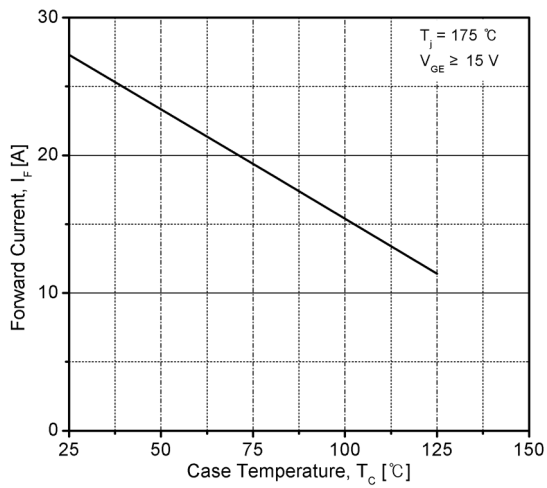


Fig 22. Case Temperature vs. Forward Current

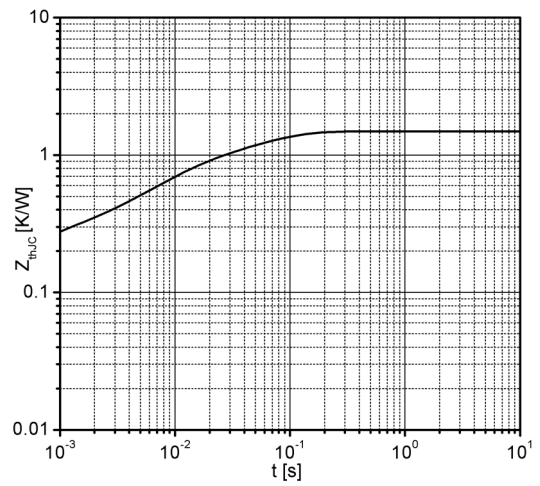


Fig 23. Typical IGBT Thermal Impedance

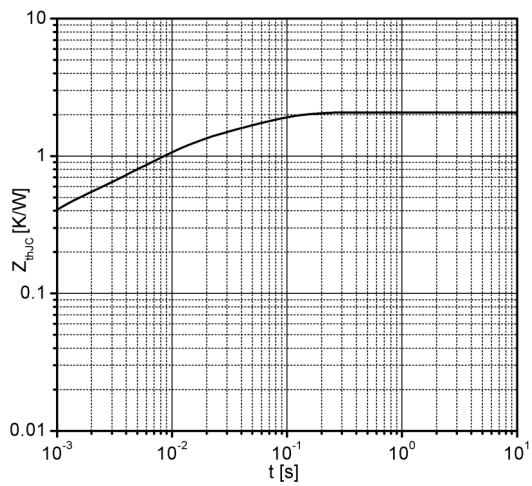


Fig 24. Typical Diode Thermal Impedance

Transistor-Brake/Diode-Brake

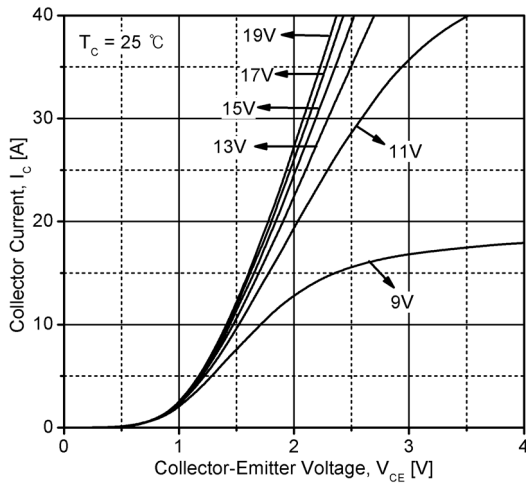


Fig 25. Typical IGBT Output Characteristics

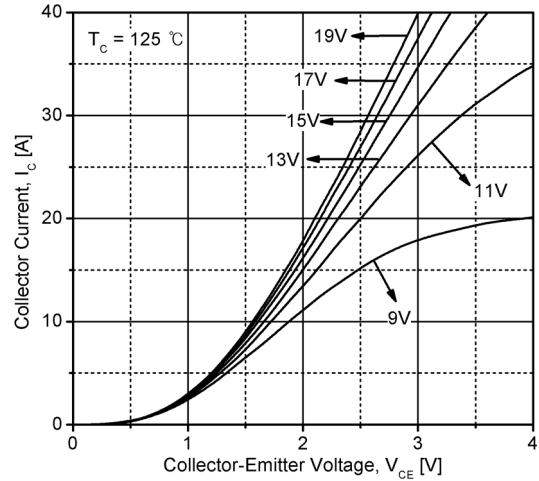


Fig 26. Typical IGBT Output Characteristics

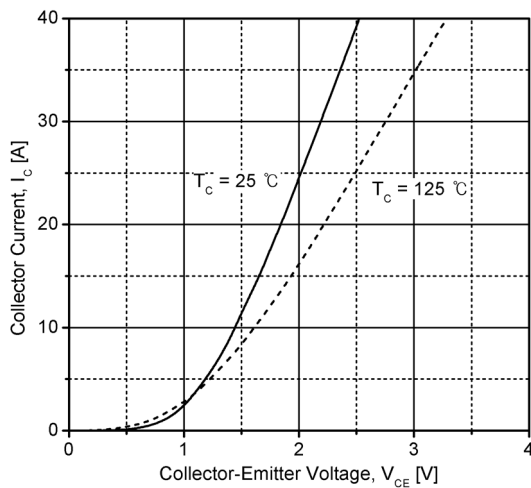


Fig 27. Typical IGBT Output Characteristics

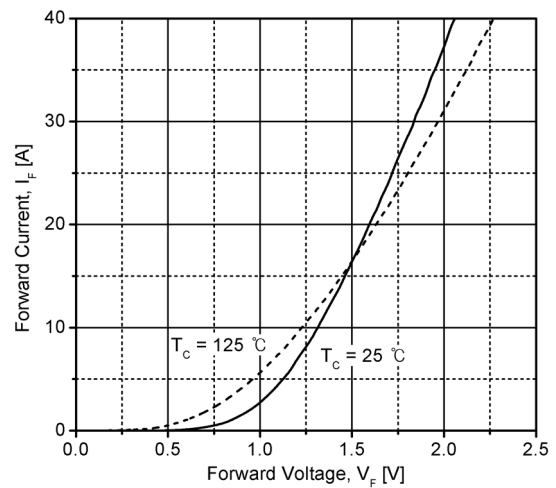


Fig 28. Typical Diode Forward Characteristics

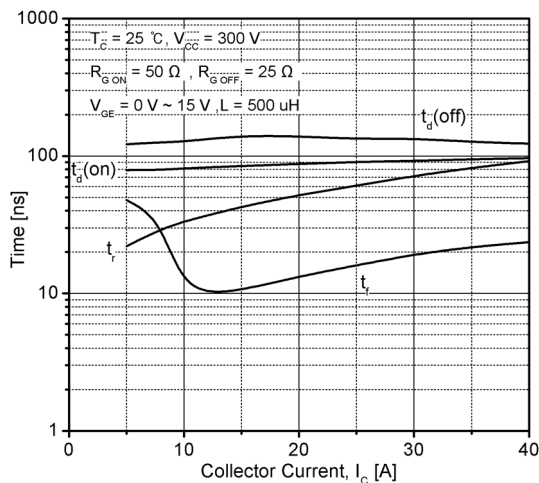


Fig 29. Typical Switching Time vs. Collector Current

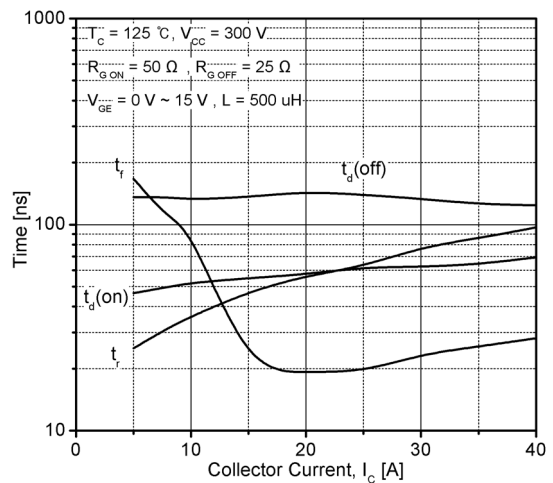


Fig 30. Typical Switching Time vs. Collector Current

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## Transistor-Brake/Diode-Brake

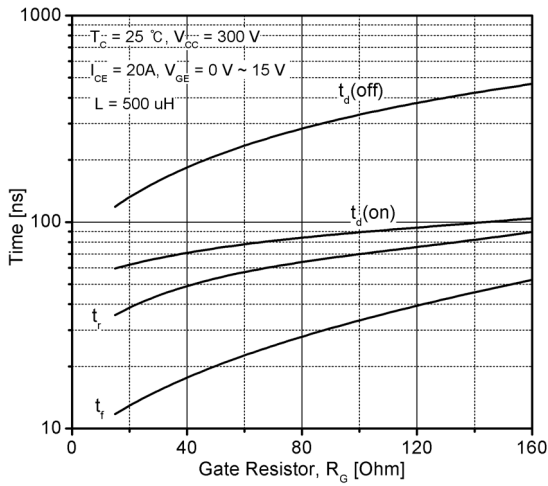


Fig 31. Typical Switching Time vs. Gate Resistor

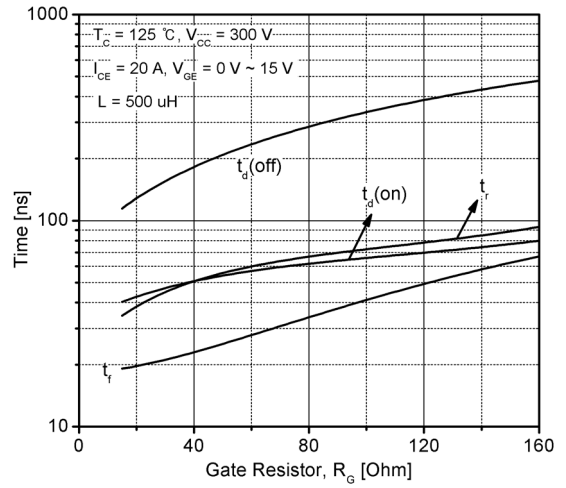


Fig 32. Typical Switching Time vs. Gate Resistor

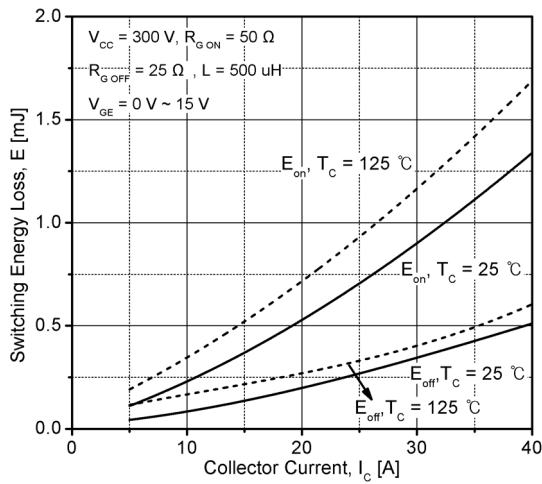


Fig 33. Typical IGBT Switching Loss

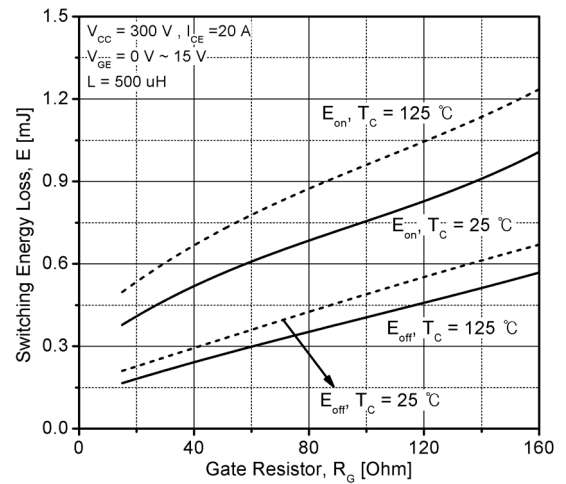


Fig 34. Typical IGBT Switching Loss

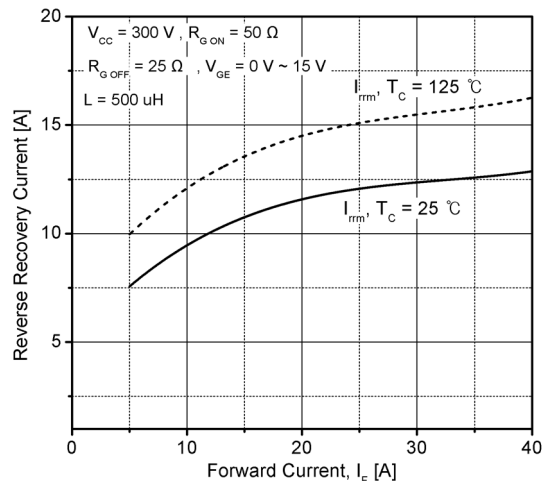


Fig 35. Typical Recovery Characteristics of Diode

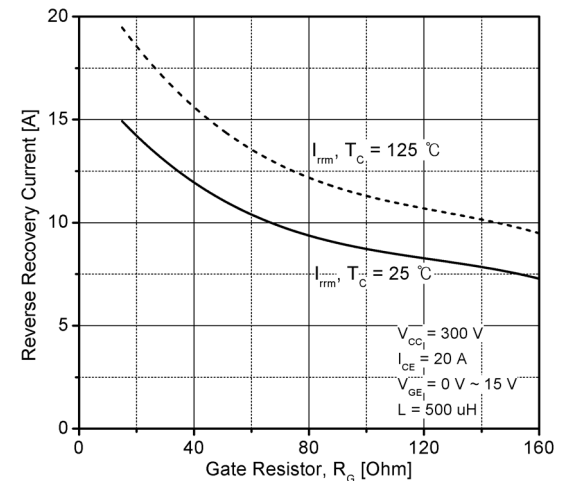


Fig 36. Typical Recovery Characteristics of Diode

Transistor-Brake/Diode-Brake

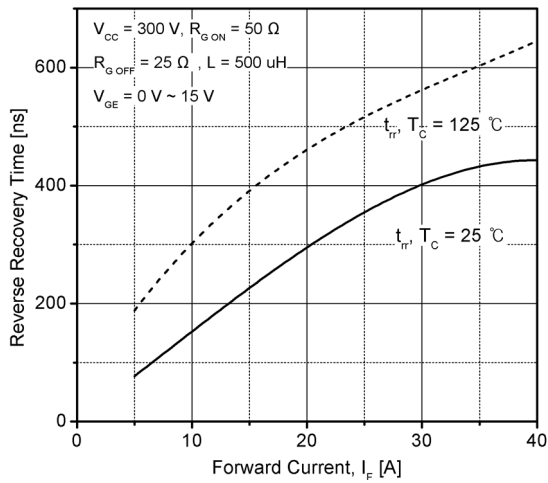


Fig 37. Typical Recovery Characteristics of Diode

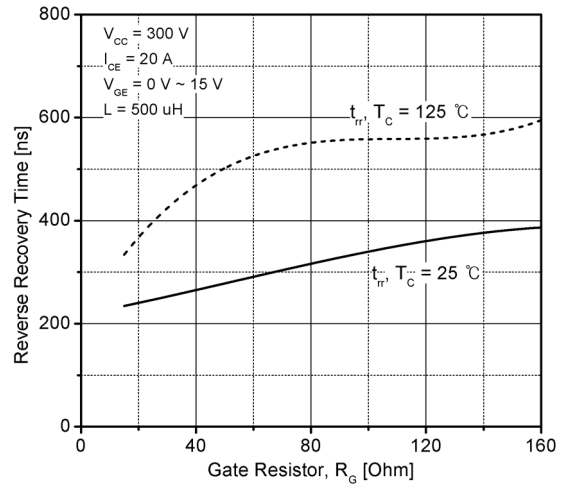


Fig 38. Typical Recovery Characteristics of Diode

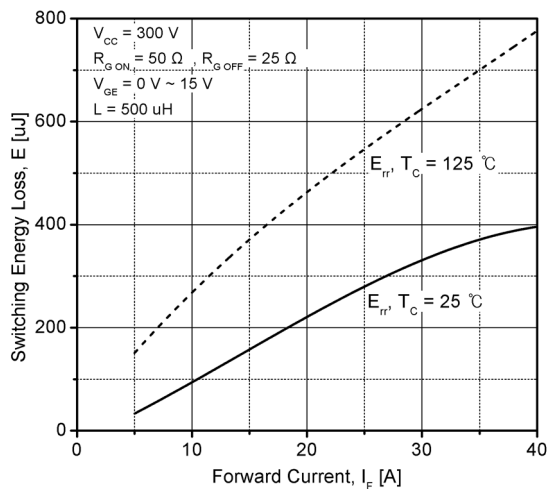


Fig 39. Typical Diode Switching Loss

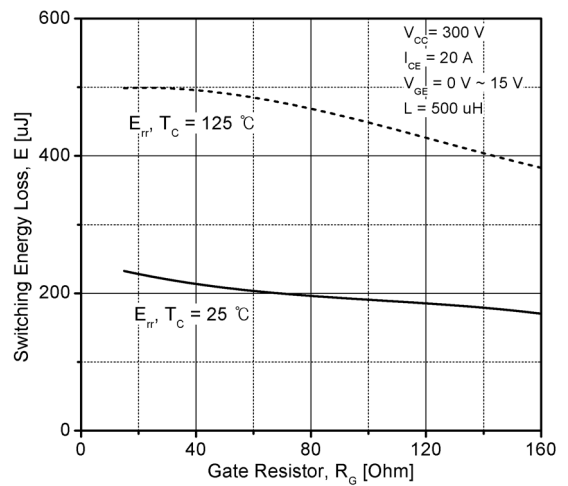


Fig 40. Typical Diode Switching Loss

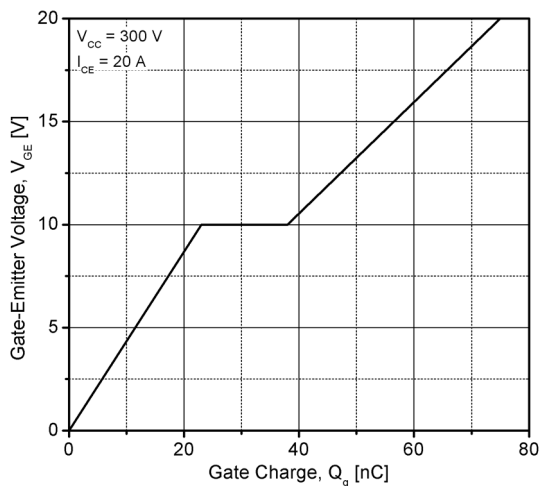


Fig 41. Typical Gate Charge Characteristics

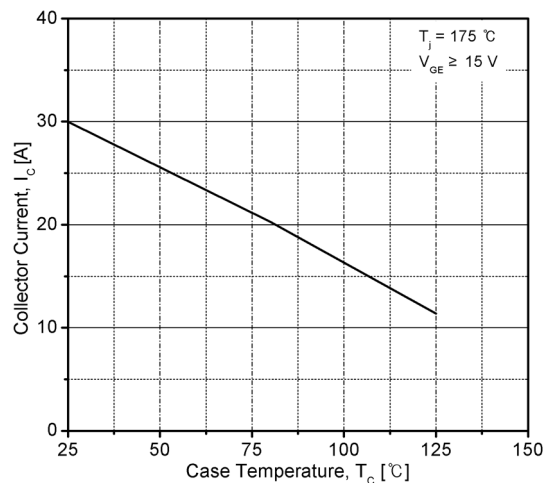


Fig 42. Case Temperature vs. Collector Current

## Transistor-Brake/Diode-Brake

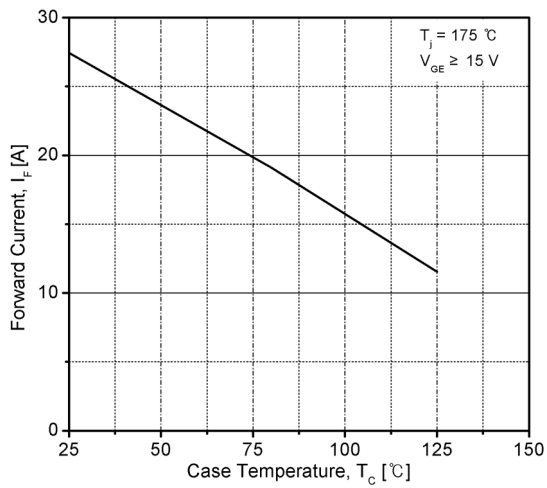


Fig 43. Case Temperature vs. Forward Current

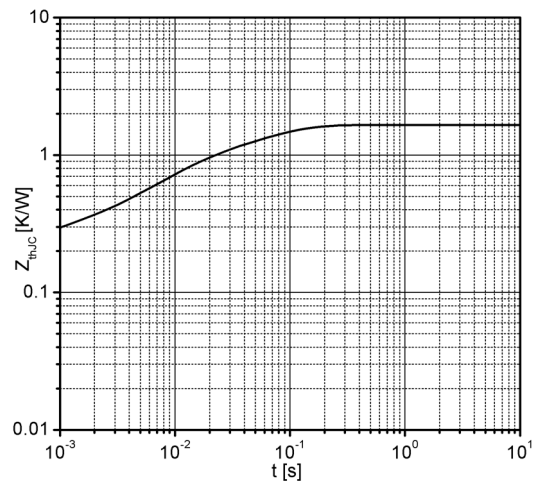


Fig 44. Typical IGBT Thermal Impedance

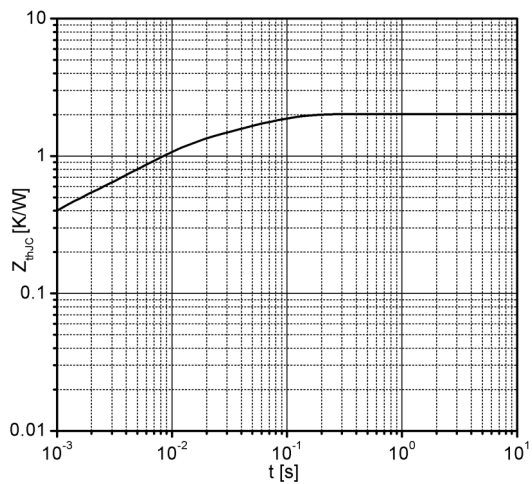
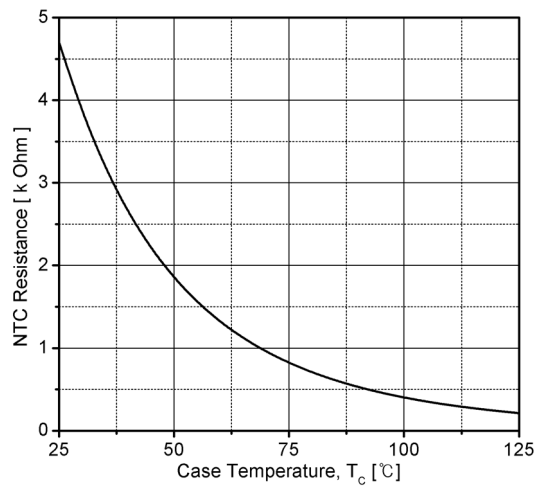


Fig 45. Typical Diode Thermal Impedance

## NTC

**Fig 46. Typical NTC Characteristics**

# LEC20G604

## Package Dimension(Dimension in mm)

